

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/824,828	WICKSTEAD, JAMES	
	Examiner	Art Unit	
	Raymond B. Persino	2682	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0132582	09-2002	Mooney, Philip D.	455/41
	B	US-6,549,791	04-2003	Jeon et al.	455/572
	C	US-6,560,468	05-2003	Boesen, Peter V.	455/569.1
	D	US-2002/0065041	05-2002	Lunsford et al.	455/41
	E	US-5,771,438	06-1998	Palermo et al.	455/41.1
	F	US-5,943,627	08-1999	Kim et al.	455/569.1
	G	US-6,459,890	10-2002	Kim, Jae Wook	455/351
	H	US-6,535,461	03-2003	Karhu, Jukka-Matti	368/10
	I	US-6,192,253	02-2001	Charlier et al.	455/575.7
	J	US-6,564,075	05-2003	Mitamura, Gen	455/575.1
	K	US-2001/0011025	08-2001	Ohki et al.	455/556
	L	US-2001/0014618	08-2001	Martin et al.	455/575
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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